INTERNATIONAL STANDARD

IEC 60938-2

QC 280100

1999

AMENDMENT 1 2006-10

Amendment 1

Fixed inductors for electromagnetic interference suppression –

Part 2:

Sectional specification

999/AMD1:2006

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International Electrotechnical Commission, 3, rue de Varembé, PO Box 131, CH-1211 Geneva 20, Switzerland Telephone: +41 22 919 02 11 Telefax: +41 22 919 03 00 E-mail: inmail@iec.ch Web: www.iec.ch



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FOREWORD

This amendment has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment.

The text of this amendment is based on the following documents:

CDV	Report on voting		
40/1603/CDV	40/1700A/RVC		

Full information on the voting for the approval of this amendment can be found in the report on voting indicated in the above table.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed;
- withdrawn;
- · replaced by a revised edition, or
- · amended.

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1.3 Normative references

Add, to the list of references, the following new reference:

CISPR 16-1-1:2003, Specification for radio disturbance and immunity measuring apparatus and methods – Part 1-1. Radio disturbance and immunity measuring apparatus – Measuring apparatus

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4.2 Voltage proof

Replace the existing Table 3 by the following new Table 3:

Table 3 - Measuring points

Inductors for	Test A between terminations*	Test B – Internal insulation) Test C – External insulation Test D** – Between windings and core
Alternating current	4,3 U _R (d.c.)	2 <i>U</i> _R + 1 500 V (a.c.) with a minimum of 2 000 V (a.c.)
Direct current	3 U _R (d.c.)	2 U _R + 1 500 V (d.c.)

^{*} Applies only to inductors with more than one winding.

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Replace the existing Annex A by the following new Annex A:

Annex A (normative)

Test schedule for safety tests only approval

ſ										
	Subc	lause number and test	D or	Conditions of test	Number of specimens (n)	Performance requirements				
	(s	eee Note 1)	ND (see Note 2)	(see Note 1)	and number of non-conforming items (c)	(see Note 1)				
	Group 4.1.1	Dimensions (gauging)	ND		See tables 1 or 2	See detail specification				
ta	4.1 ndards	Visual examination		ds/10/88/03/4 c165-4	MD1:2 <mark>006</mark> 796-9217-c4e20	No visible damage Legible marking 938-2-199	9-amd1-2006			
	4.5	DC line resistance				See detail specification				
	4.4	Inductance				Within specified tolerance				
	4.2	Voltage proof		See Table 3 See detail specification for the method Foil method duration: 1 min		No breakdown or flashover				
	4.3	Insulation resistance	\searrow	See detail specification for the method	\	As in 4.3				

^{**} Test not required for insulated or non-insulated and self-supporting mountable inductors.

Subclause number and test (see Note 1)		D or ND (see Note 2)	Conditions of test (see Note 1)	Number of specimens (n) and number of non-conforming items (c)	Performance requirements (see Note 1)	
Group	1A	D		See Tables 1		
4.1.2	Dimensions (detail)			or 2	See detail specification and 4.1.2	
	Creepage distances and clearances		For method and severity: see detail specification			
4.6	Robustness of terminations		See detail specification for the method (1A or 1B)		No visible damage	
4.7	Resistance to soldering heat (if applicable)		For method 1A: Immersion time: 10 s, unless otherwise specified in the detail specification			
4.20	Component solvent resistance (if applicable)					
4.7.2	Final measurements		DC line resistance		As in group 0	
			Voltage proof at 66 % of value in table 3	Cally	No breakdown or flashover	
		(ht	Visual examination	you itah	No visible damage	
Group	2	D		See Tables 1 or 2		
4.15	Damp heat, steady state	\ \	Recovery: 1 h to 26 h	Preview		
4.15.1	Final measurement		Visual examination	<u>MD1:2006</u>	No visible damage Legible marking	
andaro	ls.iteh.ai/catalo		DC line resistance	796-921 7 -c4e20	As in group 060938-2-199 J-amd1-2006	
		\wedge	Inductance	▼ See Tables	Within ± 30 % of value	
			Voltage proof Voltage: 66 % of voltage applied in group 0	1 or 2	measured in group 0 No breakdown or flashover	
			A polarizing voltage shall be applied if specified in the detail specification			
		_	Insulation resistance		≥50 % of value in 4.3	

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Subclause number and test (see Note 1)	or ND (see Note 2)	Conditions of test (see Note 1)	Number of specimens (n) and number of non-conforming items (c)	Performance requirements (see Note 1)	
Group 3A	D		See Tables 1		
4.16 Temperature rise (inductors with mass >5 g only)		Duration: until thermal equilibrium has been reached	or 2		
4.16.1 Test		Current: rated current			
conditions		Ambient temperature: rated temperature			
4.16.2 Final measurements					
4.18.1 Endurance, current (inductors with mass ≤5 g		Internal temperature Duration: 1 000 h Current: 1,1 × rated current		As in 4.16.2	
only)		Recovery: 1 h to 26 h			
Group 3B (inductors with more than one	D	iTe Xxn	See Tables		
winding only) 4.17 Impulse voltage	(ht	3 impulses, full wave Crest voltage: see 4.17.1	d teh	No breakdown or flashover	
4.18.2 Endurance, voltage between line terminations		Duration: 1 000 h Voltage and temperature, see 4.18.2	eview		
//st Group 3 teh.ai/catal	$\rightarrow \rightarrow$	rds/1/280/030/4-c1b5-4	79 See Tables 20	:77cef1/iec-60938-2-199	
4.18.3 Final	\wedge	Resovery: 1 h to 26 h	1 or 2		
measurements		Visual examination		No visible damage Legible marking	
		DC line resistance		As for group 0	
		Voltage proof Voltage: 66 % of voltage applied in group 0		No breakdown or flashover	
	Ť	Insulation resistance		≥50 % of values in 4.3	
Group 4	D		See Tables		
4.19 Passive flammability (if required in the detail specification)			1 or 2	As in 4.19	
<u> </u>		st and performance requireme	nto refer to Clause 4		

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Replace the existing Annex B by the following new Annex B:

Annex B (normative)

Test schedule for safety tests and performance tests for qualification approval, assessment level D

[Subc	lause number	D	Conditions of test	Number of	Performance	Ī
		and test	or ND		specimens (n) and number of	requirements	
	(5	see Note 1)	(see	(see Note 1)	non-conforming	(see Note 1)	
	Craur	. 0	Note 2)		items (c) See Tables 1		
	Group	0 0	ND		or 2		
	4.1.1	Dimensions (gauging)				See detail specification	
	4.1	Visual examination				No visible damage Legible marking	
	4.5	DC line resistance		iTe	\(\(\rangle\)\(\rangle\)	See detail specification	
	4.4	Inductance				Within specified tolerance	
	4.2	Voltage proof	(ht	See table 3 See detail specification for the method	teh	No breakdown or flashover	
1 1/ .	4.3	Insulation resistance		Foil method duration: 1 min See detail specification for the method	MD1:2,106	As in 4.3	11 0000
https://sta	Group	1Acii.ai/Cataid	B/	13/19/10/03/34-0103-4	See Tables 1	: / / cel1/lec-00938-2-199	9-amd1-2006
	4.1.2	Dimensions (detail)			or 2	See detail specification and 4.1.2	
	4.6	Robustness of terminations		For method and severity: see detail specification		No visible damage	
	4.7	Resistance to soldering heat (if applicable)		See detail specification for the method (1A or 1B) For method 1A: Immersion time: 10 s, unless otherwise specified in the detail specification			
	4.20	Component solvent resistance (if applicable)					
	4.7.2			Visual examination		No visible damage	
		measurements		DC line resistance	•	As in group 0	